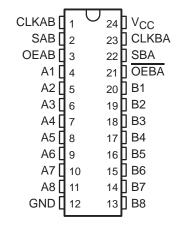
- State-of-the-Art EPIC-IIB™ BiCMOS Design Significantly Reduces Power Dissipation
- ESD Protection Exceeds 2000 V Per MIL-STD-883, Method 3015; Exceeds 200 V Using Machine Model (C = 200 pF, R = 0)
- Latch-Up Performance Exceeds 500 mA Per JEDEC Standard JESD-17
- Typical V<sub>OLP</sub> (Output Ground Bounce)
  1 V at V<sub>CC</sub> = 5 V, T<sub>A</sub> = 25°C
- High-Drive Outputs (-32-mA I<sub>OH</sub>, 64-mA I<sub>OL</sub>)
- Package Options Include Plastic Small-Outline (DW), Shrink Small-Outline (DB), and Thin Shrink Small-Outline (PW) Packages, Ceramic Chip Carriers (FK), Ceramic Flat (W) Package, and Plastic (NT) and Ceramic (JT) DIPs

#### description

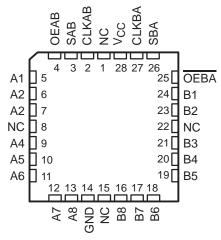
These devices consist of bus-transceiver circuits, D-type flip-flops, and control circuitry arranged for multiplexed transmission of data directly from the data bus or from the internal storage registers.

Output-enable (OEAB and OEBA) inputs are provided to control the transceiver functions. Select-control (SAB and SBA) inputs are provided to select either real-time or stored data for transfer. The circuitry used for select control eliminates the typical decoding glitch that occurs in a multiplexer during the transition between stored and real-time data. A low input selects real-time data, and a high input selects stored data. Figure 1 illustrates the four fundamental bus-management functions that can be performed with the 'ABT652A.

#### SN54ABT652A . . . JT OR W PACKAGE SN74ABT652A . . . DB, DW, NT, OR PW PACKAGE (TOP VIEW)



## SN54ABT652A . . . FK PACKAGE (TOP VIEW)



NC - No internal connection

Data on the A- or B-data bus, or both, can be stored in the internal D-type flip-flops by low-to-high transitions at the appropriate clock (CLKAB or CLKBA) inputs, regardless of the select- or enable-control inputs. When SAB and SBA are in the real-time transfer mode, it is possible to store data without using the internal D-type flip-flops by simultaneously enabling OEAB and OEBA. In this configuration, each output reinforces its input. When all other data sources to the two sets of bus lines are at high impedance, each set of bus lines remains at its last state.

To ensure the high-impedance state during power up or power down,  $\overline{\text{OEBA}}$  should be tied to  $V_{CC}$  through a pullup resistor; the minimum value of the resistor is determined by the current-sinking capability of the driver (B to A). OEAB should be tied to GND through a pulldown resistor; the minimum value of the resistor is determined by the current-sourcing capability of the driver (A to B).



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

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#### description (continued)

The SN54ABT652A is characterized for operation over the full military temperature range of  $-55^{\circ}$ C to  $125^{\circ}$ C. The SN74ABT652A is characterized for operation from  $-40^{\circ}$ C to  $85^{\circ}$ C.

#### **FUNCTION TABLE**

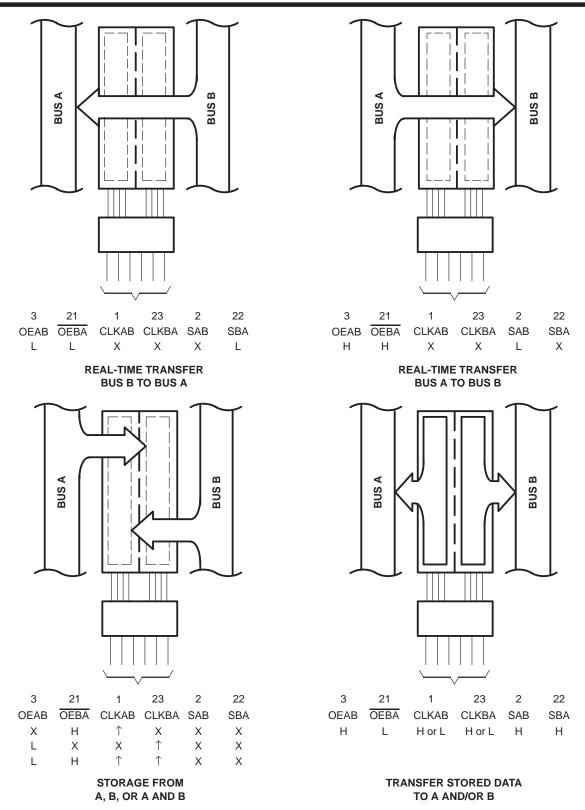
|      | INPUT |            | UTS        |                |     | DATA                     | 1/0†                     | ODED ATION OF FUNCTION                            |
|------|-------|------------|------------|----------------|-----|--------------------------|--------------------------|---|
| OEAB | OEBA  | CLKAB      | CLKBA      | SAB            | SBA | A1–A8                    | B1-B8                    | OPERATION OR FUNCTION                             |
| L    | Н     | H or L     | H or L     | Х              | Х   | Input                    | Input                    | Isolation   |
| L    | Н     | 1          | <b>↑</b>   | Χ              | Χ   | Input                    | Input                    | Store A and B data                                |
| Х    | Н     | 1          | H or L     | Х              | Χ   | Input                    | Unspecified <sup>‡</sup> | Store A, hold B                                   |
| Н    | Н     | $\uparrow$ | $\uparrow$ | X <sup>‡</sup> | Χ   | Input                    | Output                   | Store A in both registers                         |
| L    | Χ     | H or L     | <b>↑</b>   | Х              | Χ   | Unspecified <sup>‡</sup> | Input                    | Hold A, store B                                   |
| L    | L     | 1          | <b>↑</b>   | Х              | X‡  | Output                   | Input                    | Store B in both registers                         |
| L    | L     | Х          | Х          | Х              | L   | Output                   | Input                    | Real-time B data to A bus                         |
| L    | L     | Χ          | H or L     | X              | Н   | Output                   | Input                    | Stored B data to A bus                            |
| Н    | Н     | Х          | Х          | L              | Х   | Input                    | Output                   | Real-time A data to B bus                         |
| Н    | Н     | H or L     | Χ          | Н              | Χ   | Input                    | Output                   | Stored A data to B bus                            |
| Н    | L     | H or L     | H or L     | Н              | Н   | Output                   | Output                   | Stored A data to B bus and stored B data to A bus |

<sup>†</sup> The data-output functions may be enabled or disabled by a variety of level combinations at OEAB or OEBA. Data-input functions are always enabled; i.e., data at the bus terminals is stored on every low-to-high transition of the clock inputs.



<sup>‡</sup> Select control = L; clocks can occur simultaneously.

Select control = H; clocks must be staggered to load both registers.



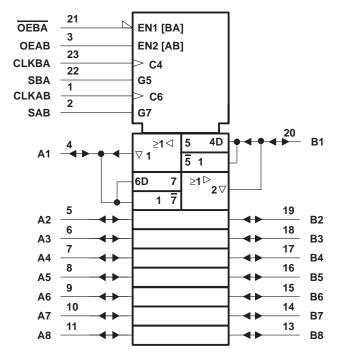
Pin numbers shown are for the DB, DW, JT, NT, PW, and W packages.

Figure 1. Bus-Management Functions



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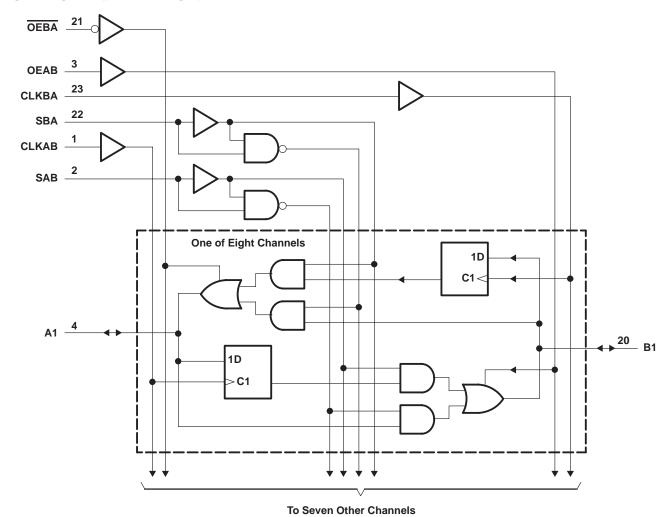
## logic symbol†



<sup>&</sup>lt;sup>†</sup> This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12. Pin numbers shown are for the DB, DW, JT, NT, PW, and W packages.



## logic diagram (positive logic)



Pin numbers shown are for the DB, DW, JT, NT, PW, and W packages.

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### absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

| Supply voltage range, V <sub>CC</sub>                       | –0.5 V to 7 V                                |
|---|--|
|   | ) –0.5 V to 7 V                              |
| Voltage range applied to any output in the high or pov      | ver-off state, V <sub>O</sub> 0.5 V to 5.5 V |
| Current into any output in the low state, IO: SN54AB        | Г652A 96 mA                                  |
| SN74AB  | Г652A  |
| Input clamp current, $I_{IK}$ ( $V_I < 0$ )                 | −18 mA                                       |
| Output clamp current, I <sub>OK</sub> (V <sub>O</sub> < 0)  |  |
| Package thermal impedance, $\theta_{JA}$ (see Note 2): DB p | ackage 104°C/W                               |
| DW p  | package 81°C/W                               |
| NT p  | ackage 67°C/W                                |
| PW p  | ackage 120°C/W                               |
| Storage temperature range, T <sub>stg</sub>                 |  |

<sup>†</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. The input and output negative-voltage ratings may be exceeded if the input and output clamp-current ratings are observed.

2. The package thermal impedance is calculated in accordance with EIA/JEDEC Std JESD51, except for through-hole packages, which use a trace length of zero.

#### recommended operating conditions (see Note 3)

|  |                                    |                 | SN54AB          | T652A | SN74AB | T652A | UNIT |
|--|------------------------------------|-----------------|-----------------|-------|--------|-------|------|
|  |                                    |                 | MIN             | MAX   | MIN    | MAX   | UNIT |
| VCC                                      | Supply voltage                     |                 | 4.5             | 5.5   | 4.5    | 5.5   | V    |
| V <sub>IH</sub> High-level input voltage |                                    |                 | 2               |       | 2      |       | V    |
| V <sub>IL</sub>                          | /IL Low-level input voltage        |                 |                 | 0.8   |        | 0.8   | V    |
| VI                                       | V <sub>I</sub> Input voltage       |                 | 0               | VCC   | 0      | VCC   | V    |
| loh                                      | High-level output current          |                 |                 | -24   |        | -32   | mA   |
| IOL                                      | OL Low-level output current        |                 |                 | 48    |        | 64    | mA   |
| Δt/Δν                                    | Input transition rise or fall rate | Outputs enabled |                 | 5     |        | 5     | ns/V |
| TA                                       | Operating free-air temperature     |                 | <del>-</del> 55 | 125   | -40    | 85    | °C   |

NOTE 3: Unused pins (input or I/O) must be held high or low to prevent them from floating.



## electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

| PARAMETER                   | TEST CO  | TEST CONDITIONS  |     |                  | T <sub>A</sub> = 25°C |     |      | SN74ABT652A |      | UNIT |  |
|-----------------------------|--|--|-----|------------------|-----------------------|-----|------|-------------|------|------|--|
| PARAWEIER                   | 1251 00  | MUITIONS   | MIN | TYP <sup>†</sup> | MAX                   | MIN | MAX  | MIN         | MAX  | UNII |  |
| VIK                         | $V_{CC} = 4.5 V,$                                  | $I_{I} = -18 \text{ mA}$   |     |                  | -1.2                  |     | -1.2 |             | -1.2 | V    |  |
|                             | $V_{CC} = 4.5 \text{ V},$                          | $I_{OH} = -3 \text{ mA}$   | 2.5 |                  |                       | 2.5 |      | 2.5         |      |      |  |
| V                           | $V_{CC} = 5 V$                                     | $I_{OH} = -3 \text{ mA}$   | 3   |                  |                       | 3   |      | 3           |      | V    |  |
| VOH                         | V <sub>CC</sub> = 4.5 V                            | $I_{OH} = -24 \text{ mA}$  | 2   |                  |                       | 2   |      |             |      | V    |  |
|                             | VCC = 4.5 V  | $I_{OH} = -32 \text{ mA}$  | 2*  |                  |                       |     |      | 2           |      |      |  |
| Voi                         | V <sub>CC</sub> = 4.5 V                            | I <sub>OL</sub> = 48 mA  |     |                  | 0.55                  |     | 0.55 |             |      | V    |  |
| VOL                         | VCC = 4.5 V  | $I_{OL} = 64 \text{ mA}$   |     |                  | 0.55*                 |     |      |             | 0.55 | v I  |  |
| V <sub>hys</sub>            |  |  |     | 100              |                       |     |      |             |      | mV   |  |
| Control inp                 | uts V <sub>CC</sub> = 5.5 V,                       | V <sub>I</sub> = V <sub>CC</sub> or GND  |     |                  | ±1                    |     | ±1   |             | ±1   | μΑ   |  |
| A or B port                 | s VCC = 3.5 v,                                     |  |     |                  | ±100                  |     | ±100 |             | ±100 |      |  |
| lozh <sup>‡</sup>           | $V_{CC} = 5.5 V$ ,                                 | $V_0 = 2.7 \text{ V}$  |     |                  | 50**                  |     | 10   |             | 50   | μΑ   |  |
| lozL <sup>‡</sup>           | $V_{CC} = 5.5 V$ ,                                 | V <sub>O</sub> = 0.5 V   |     |                  | -50**                 |     | -10  |             | -50  | μΑ   |  |
| loff                        | $V_{CC} = 0$ ,                                     | $V_I$ or $V_O \le 4.5 \text{ V}$   |     |                  | ±100                  |     |      |             | ±100 | μΑ   |  |
| ICEX                        | V <sub>CC</sub> = 5.5 V,<br>V <sub>O</sub> = 5.5 V | Outputs high   |     |                  | 50                    |     | 50   |             | 50   | μΑ   |  |
| IO§                         | V <sub>CC</sub> = 5.5 V,                           | V <sub>O</sub> = 2.5 V   | -50 | -100             | -180                  | -50 | -180 | -50         | -180 | mA   |  |
|                             | V <sub>CC</sub> = 5.5 V,                           | Outputs high   |     |                  | 250                   |     | 250  |             | 250  | μΑ   |  |
| Icc                         | $I_{O} = 0$ ,                                      | Outputs low  |     |                  | 30                    |     | 30   |             | 30   | mA   |  |
|                             | $V_I = V_{CC}$ or GND                              | Outputs disabled   |     |                  | 250                   |     | 250  |             | 250  | μΑ   |  |
| ΔICC¶                       |  | V <sub>CC</sub> = 5.5 V, One input at 3.4 V,<br>Other inputs at V <sub>CC</sub> or GND |     |                  | 1.5                   |     | 1.5  |             | 1.5  | mA   |  |
| C <sub>i</sub> Control inp  | uts V <sub>I</sub> = 2.5 V or 0.5 V                |  |     | 7                |                       |     |      |             |      | pF   |  |
| C <sub>io</sub> A or B port | $V_0 = 2.5 \text{ V or } 0.5 \text{ V}$            | /  |     | 12               |                       |     |      |             |      | pF   |  |

<sup>\*</sup> On products compliant to MIL-PRF-38535, this parameter does not apply.



<sup>\*\*</sup> These limits apply only to the SN74ABT652A.

<sup>&</sup>lt;sup>†</sup> All typical values are at  $V_{CC} = 5 \text{ V}$ .

<sup>&</sup>lt;sup>‡</sup>The parameters I<sub>OZH</sub> and I<sub>OZL</sub> include the input leakage current.

<sup>§</sup> Not more than one output should be tested at a time, and the duration of the test should not exceed one second.

<sup>¶</sup> This is the increase in supply current for each input that is at the specified TTL voltage level rather than V<sub>CC</sub> or GND.

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timing requirements over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (see Figure 2)

|                 |  |                                      | SN54AE         | 3T652A |     |      |
|-----------------|--|--------------------------------------|----------------|--------|-----|------|
|                 |  | V <sub>CC</sub> = T <sub>A</sub> = 2 | = 5 V,<br>25°C | MIN    | MAX | UNIT |
|                 |  | MIN                                  | MAX            | 1      |     |      |
| fclock          | Clock frequency                            | 0                                    | 125            | 0      | 125 | MHz  |
| t <sub>W</sub>  | Pulse duration, CLK high or low            | 4                                    |                | 4      |     | ns   |
| t <sub>su</sub> | Setup time, A or B before CLKAB↑ or CLKBA↑ | 3                                    |                | 3.5    |     | ns   |
| th              | Hold time, A or B after CLKAB↑ or CLKBA↑   | 1.5                                  |                | 1.5    |     | ns   |

timing requirements over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (see Figure 2)

|                 |  |                   | SN74AE         | 3T652A |     |      |
|-----------------|--|-------------------|----------------|--------|-----|------|
|                 |  | V <sub>CC</sub> = | = 5 V,<br>25°C | MIN    | MAX | UNIT |
|                 |  | MIN MAX           |                |        |     |      |
| fclock          | Clock frequency                            | 0                 | 125            | 0      | 125 | MHz  |
| t <sub>W</sub>  | Pulse duration, CLK high or low            | 4                 |                | 4      |     | ns   |
| t <sub>su</sub> | Setup time, A or B before CLKAB↑ or CLKBA↑ | 3                 |                | 3      |     | ns   |
| th              | Hold time, A or B after CLKAB↑ or CLKBA↑   | 0                 |                | 0      |     | ns   |



## switching characteristics over recommended ranges of supply voltage and operating free-air temperature, $C_L$ = 50 pF (unless otherwise noted) (see Figure 2)

| PARAMETER        | FROM<br>(INPUT) | TO<br>(OUTPUT) | V <sub>CC</sub> = 5 V,<br>T <sub>A</sub> = 25°C |     |     | MIN | MAX | UNIT |
|------------------|-----------------|----------------|---|-----|-----|-----|-----|------|
|                  |                 |                | MIN   | TYP | MAX |     |     |      |
| f <sub>max</sub> |                 |                | 125   | 200 |     | 125 |     | MHz  |
| <sup>t</sup> PLH | CLK             | B or A         | 2.2   | 4   | 5.1 | 1.7 | 5.9 | ns   |
| t <sub>PHL</sub> |                 | BOIA           | 1.7   | 4   | 5.1 | 1.7 | 5.9 | 115  |
| t <sub>PLH</sub> | A or B          | B or A         | 1.5   | 3   | 4.8 | 1   | 5   | ns   |
| t <sub>PHL</sub> |                 | BULK           | 1.5   | 3.3 | 4.6 | 1   | 5.6 | 110  |
| t <sub>PLH</sub> | 040 004         | B or A         | 1.5   | 4   | 5.5 | 1.5 | 6.8 | ns   |
| <sup>t</sup> PHL | SAB or SBA†     | BOIA           | 1.5   | 3.6 | 4.9 | 1.5 | 6.2 | 115  |
| <sup>t</sup> PZH | <del>OEBA</del> | А              | 2   | 3.6 | 5.4 | 2   | 6.8 | ns   |
| t <sub>PZL</sub> | OEBA            |                | 3   | 5.7 | 7.7 | 3   | 9.2 |      |
| t <sub>PHZ</sub> | OFDA.           | А              | 1.5   | 3.2 | 5.8 | 1   | 7.5 | ns   |
| t <sub>PLZ</sub> | OEBA            |                | 1.5   | 3   | 4.3 | 1   | 4.6 | 115  |
| <sup>t</sup> PZH | OEAB            | В              | 2   | 4.3 | 6.1 | 2   | 7.8 | ns   |
| t <sub>PZL</sub> |                 | В              | 3   | 5.5 | 7.4 | 3   | 8.9 | 110  |
| <sup>t</sup> PHZ | OEAB            | В              | 1.5   | 3.3 | 6   | 1   | 8   |      |
| t <sub>PLZ</sub> | OLAD            | В              | 1.5   | 3.4 | 5   | 1.5 | 6.8 | ns   |

<sup>†</sup>These parameters are measured with the internal output state of the storage register opposite that of the bus input.

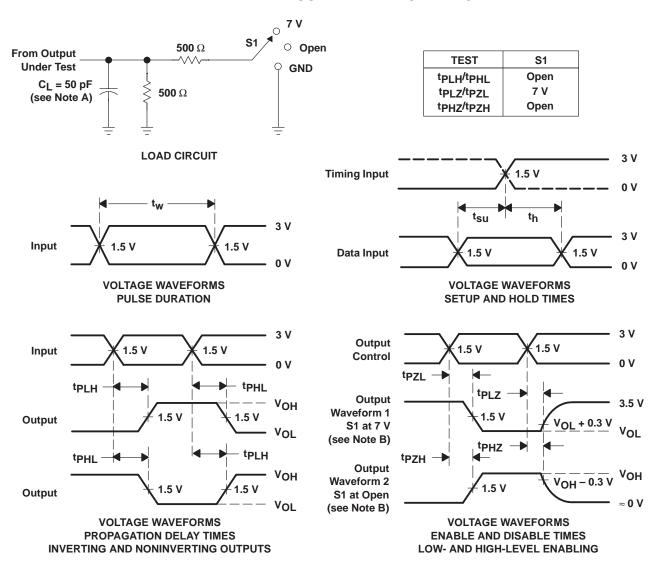
# switching characteristics over recommended ranges of supply voltage and operating free-air temperature, $C_L$ = 50 pF (unless otherwise noted) (see Figure 2)

| PARAMETER        | FROM<br>(INPUT) | TO<br>(OUTPUT) | V <sub>CC</sub> = 5 V,<br>T <sub>A</sub> = 25°C |     |     | MIN | MAX | UNIT |
|------------------|-----------------|----------------|---|-----|-----|-----|-----|------|
|                  |                 |                | MIN   | TYP | MAX |     |     |      |
| f <sub>max</sub> |                 |                | 125   | 200 |     | 125 |     | MHz  |
| t <sub>PLH</sub> | CLK             | B or A         | 2.2   | 4   | 5.1 | 2.2 | 5.6 | ns   |
| <sup>t</sup> PHL |                 | DOIA           | 1.7   | 4   | 5.1 | 1.7 | 5.6 | 115  |
| t <sub>PLH</sub> | A or B          | B or A         | 1.5   | 3   | 4.3 | 1.5 | 4.8 | ns   |
| t <sub>PHL</sub> |                 | BUIA           | 1.5   | 3.3 | 4.6 | 1.5 | 5.4 | 110  |
| t <sub>PLH</sub> | 045 054         | B or A         | 1.5   | 4   | 5.1 | 1.5 | 6.5 | ns   |
| t <sub>PHL</sub> | SAB or SBA†     | BULA           | 1.5   | 3.6 | 4.9 | 1.5 | 5.9 | 115  |
| <sup>t</sup> PZH | <del>OEBA</del> | А              | 2   | 3.6 | 4.6 | 2   | 5.8 | ns   |
| t <sub>PZL</sub> | OEBA            |                | 3   | 5.7 | 6.8 | 3   | 8.5 | 115  |
| <sup>t</sup> PHZ | OFDA            | А              | 1.5   | 3.2 | 4.5 | 1.5 | 5   | ns   |
| t <sub>PLZ</sub> | OEBA            |                | 1.5   | 3   | 3.8 | 1.5 | 4.1 |      |
| <sup>t</sup> PZH | OEAB            | В              | 2   | 4.3 | 6.1 | 2   | 6.5 |      |
| t <sub>PZL</sub> |                 | Ь              | 3   | 5.5 | 6.5 | 3   | 7.4 | ns   |
| <sup>t</sup> PHZ | OEAB            | В              | 1.5   | 3.3 | 4.5 | 1.5 | 5.5 | 20   |
| t <sub>PLZ</sub> | OLAD            | В              | 1.5   | 3.4 | 4.4 | 1.5 | 5.1 | ns   |

<sup>†</sup> These parameters are measured with the internal output state of the storage register opposite that of the bus input.



#### PARAMETER MEASUREMENT INFORMATION



NOTES: A. C<sub>L</sub> includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  10 MHz,  $Z_{O} = 50 \Omega$ ,  $t_{f} \leq 2.5 \text{ ns.}$
- D. The outputs are measured one at a time with one transition per measurement.

Figure 2. Load Circuit and Voltage Waveforms



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